ANALYSIS OF CHROMIUM CLAD OPTICAL WAVEGUIDE FOR TE PASS POLARIZER USING POLYMER BUFFER LAYER

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ABSTRACT:

Attenuation characteristics of chromium clad optical waveguide are theoretically investigated at the wavelength of 0.6328 \textmu m. Theoretical results are obtained by solving complex multilayer eigen value equations by Transfer Matrix Method (TMM). It is proposed that the TM mode attenuation can be significantly increased by inserting a low index polymer buffer layer between the dielectric guide and metal clad layer. By using low index polymer buffer layer a resonant coupling condition between guided modes and surface plasmon modes is obtained to improve the attenuation characteristics. The generated field profiles suggest that TE mode field is mainly confined within the waveguide thickness and TM mode field exhibit an absorption peak in metal layer at a particular buffer thickness. This property can be used to design a high extinction ratio TE pass polarizer. Effect of metal thickness and buffer layer thickness is also discussed.

KEYWORDS: Metal clad waveguide, Polarizer, Transfer matrix method, Buffer layer, Chromium cladding.

1. INTRODUCTION

Multilayer waveguides are used in implementing variety of optical devices including semiconductor lasers, modulators, waveguide polarizers and directional couplers [1-2]. Theoretical study of metal clad dielectric waveguides has been extensively covered by many researchers [4-9]. It has been already reported in previously published papers that waveguide structure with chromium can support surface Plasmon mode as well as damped leaky modes [3-4]. We proposed a multilayer optical waveguide structure with chromium as a cladding layer. It is observed that a proposed structure can support guided modes and surface plasmon modes. Surface Plasmon modes polaritons (SPPs) are electromagnetic waves coupled to the coherent oscillations of a metal’s free electron density and propagate along the interface between a dielectric and a metal [6-11]. SPPs generally have much smaller wavelength than those of free propagating electromagnetic waves which makes them a prospective candidate for compact integrated optical circuits [10]. It has been observed that chromium consist of greater attenuation than an order of magnitude over measured attenuation in silver, aluminium and gold [3]. Due to this characteristic chromium can be explored for polarization effects. In this paper we have observed the attenuation characteristics and the interaction of guided modes and modes exist due to chromium cladding in the proposed structure. We investigated two structure of chromium clad optical waveguide. One structure is analyzed for attenuation characteristics without buffer layer and in another structure buffer layer effect is also observed. It is shown that a low index polymer buffer layer can be introduced between guiding layer and clad which may produce good attenuation peaks to select a particular (TE) polarization. Chromium clad waveguide have not been exploit to a much extent for polarization properties. By analysing this structure we proposed a high extinction ratio, low insertion loss TE pass polarizer. There are many ways to produce a waveguide polarizer, e.g. using selective attenuation in metal/semiconductor cladding or cut off effect in waveguide [11-18].
Polarizer is a key component for integrated optical devices which require a single polarization for the operation. The response of the proposed structure is not much suitable to design an efficient polarizer due to low extinction ratio.

Therefore a buffer layer is introduce for the resonant coupling of guided modes (TM) to the surface Plasmon modes supported by the metal layer.

Polymer can be chosen as the buffer material. Polymers have been widely used in integrated optics because they have excellent waveguiding characteristics [19-20]. Also, the advantage of using polymer buffer layer is that, there are a large number of polymers with refractive index ranging from 1.4 to 1.7 [21].

The thin film Transfer Matrix method (TMM) is used to calculate the eigen value equation in the multilayer slab structure. The transfer matrix of each layer is calculated and the effective indices are found by solving eigen functions numerically. The method (TMM) is presented in Appendix-I.

3. Chromium Clad optical waveguide

The multilayer substrate/SiON/Cr/air structure and the coordinates are shown in Fig.1. The substrate and the waveguide (SiON) layer are considered to be lossless and are given by real refractive index values. The metal cladding layer (chromium) is characterized by complex value of refractive index. A thickness of 1.5 µm is selected for the waveguide which is sufficient to support fundamental modes.

4. Result and Discussion

In this section we will focus on the optical guided modes and surface plasmon (SP) modes supported by multilayer metal clad waveguide structure. We will also concentrate on the interaction of guided modes with the SP modes in the proposed structures as shown in Fig.2.

In the calculations, we considered \( \lambda = 0.6328 \) µm, SiON guide layer \( n_1 = 1.546 \), Substrate layer index \( n_s = 1.540 \), cladding layer (Cr) index \( n_3 = 3.19 - 2.26 i \) and air cover index \( n_c = 1.0 \). We used SiON waveguide for its highly desirable features such as low insertion loss, wide range of refractive index tailoring and realization of compact devices [22]. Fig.1 shows the chromium clad waveguide structure without buffer layer. Fig.3 shows the variation of TE and TM mode attenuation curves with the chromium thickness. As the thickness of the of chromium layer is increased mode attenuation starts increasing and reached at the peak at a particular thickness of metal layer for both polarization (TE/TM) respectively.
It can be observed that there is a difference of mode attenuation between TE and TM modes. This difference is present due to the surface plasmon modes. As the surface plasmon modes supported by metal clad waveguide structure interact only with TM guided modes supported by the waveguide layer, a mode coupling is obtained. Due to this coupling of SP modes which are transverse magnetic in nature with TM guided modes, almost all the energy of TM guided modes absorbed by the metal layer. Hence, there is no much attenuation exist for TE mode polarization and this property can be used to design a high extinction ratio TE pass polarizer.

4.1. Effect of buffer layer and TE pass polarizer

Chromium layer has been already used in various multilayer waveguide structure as a positive permittivity metal substrate and its mode attenuation characteristics has been observed [3]. But its characteristics has not been studied to a much extent with a role of cladding layer in waveguide. Buffer layer effects are also to be discussed in detail to design optical devices with this kind of structure [3].

Fig. 2 shows the proposed structure with polymer buffer layer. Fig.4 and Fig.5 shows the attenuation characteristics of TE and TM modes polarization respectively for the proposed buffered structure. It can be observed that due to introduction of polymer buffer layer the attenuation characteristics have drastically changed. Now, a large difference in attenuation value for TE and TM polarizations can be noticed. With the buffered structure, 100 nm thickness of chromium is used as an optimized value. Due to buffer layer a resonant coupling between guided TM modes and surface plasmon modes is achieved. In other words, an excellent phase matching takes place between SP mode and TM guided modes and all the energy of guided TM modes is absorbed in the metal layer. As surface plasmon do not interact with guided TE modes, all the energy of the TE guided modes is confined within the guiding layer. Hence, there is no much attenuation exist for TE mode polarization and this property can be used to design a high extinction ratio, low insertion loss TE pass polarizer. For designing a TE pass polarizer an optimized thickness of buffer layer is chosen. At this optimized thickness (0.43 µm) the maximum attenuation for TM mode polarization is 91354 dB/cm and corresponding TE mode attenuation is 14 dB/cm. The value of the attenuation curves strongly suggest to design a high extinction ratio TE pass polarizer. Fig.6 shows the mode field profile, which also supports the design of TE pass polarizer.

It can be observed that the field of TM mode is confined in the chromium thickness and TE mode field is confined within the waveguide layer. A TE pass polarizer with extinction ratio of 9134 dB and insertion loss of 1.4 dB can be designed for the length of 1mm. Mode field profile clearly indicate that propagation of the mode for TM polarization has the nature of surface plasmon mode.
Fig. 4. Variation of TE mode attenuation as a function of buffer thickness at Cr thickness of 0.1 μm.

Fig. 5. Variation of TM mode attenuation as function of buffer thickness at Cr thickness of 0.1 μm.

Fig. 6. TE and TM mode field distribution for TE pass polarizer. (Cr thickness= 0.1 μm. and buffer thickness =0.43μm.).
6. Conclusion
We have theoretically studied the attenuation characteristics of chromium clad optical waveguide at the wavelength of 0.6328 µm. It is shown that optical waveguide clad with chromium exhibit high attenuation peak for TM polarization. This is due to the resonant coupling between surface Plasmon mode supported by metal thickness and TM guided modes supported by guiding layer. The effect of polymer layer is also observed. It is proposed that a polymer buffer layer between guiding layer and metal can largely change the attenuation characteristics of both (TE/TM) polarization. We determined that a high extinction ratio, low insertion loss TE pass polarizer can be designed by suitably choosing the structure parameters and material indices.

index \( n_{\text{eff}} \) and the absorption coefficient \( \alpha \) are given, respectively, by \([1,22-23]\)

\[
N_{\text{eff}} = \frac{\beta_{\text{re}}}{k_{n}} \quad (4)
\]

\[
\alpha = 2\beta_{\text{im}} \quad (5)
\]

The general solution of the wave equation in each homogeneous layer \((i)\) is well known

\[
F_{y,i}(x) = A_{i} \exp(k_{i}(x-x_{i})) + B_{i} \exp(-k_{i}(x-x_{i})) \quad (6)
\]

Where \( k_{i} = \sqrt{\beta^{2} - k_{o}^{2}n_{i}^{2}} \), \( A_{i} \) and \( B_{i} \) are the complex field coefficient that vary from layer to layer. By imposing the continuity conditions of the field and its derivatives for each interface, it is easy to find

\[
\begin{bmatrix}
A_{i+1} \\
B_{i+1}
\end{bmatrix}
= T_{i}
\begin{bmatrix}
A_{i} \\
B_{i}
\end{bmatrix}
\]

where

\[
T_{i} = \frac{1}{2}
\begin{bmatrix}
1+\eta_{i} \frac{k_{i}}{k_{i+1}} \exp(k_{i}d_{i}) & 1-\eta_{i} \frac{k_{i}}{k_{i+1}} \exp(-k_{i}d_{i}) \\
1-\eta_{i} \frac{k_{i}}{k_{i+1}} \exp(k_{i}d_{i}) & 1+\eta_{i} \frac{k_{i}}{k_{i+1}} \exp(-k_{i}d_{i})
\end{bmatrix}
\]

Where \( d_{i} \) is the \( i \)-th layer thickness and

\[
\eta_{i} = \begin{bmatrix}
1, & \text{TE} \\
\frac{n_{i}^{2}}{n_{i}^{2}}, & \text{TM}
\end{bmatrix}
\]

Field coefficients can be related in the cladding \(( A_{c} \) and \( B_{c} \)) with the coefficients in the substrate

\(( A_{i} \) and \( B_{i} \)) as follows:
\[ \begin{bmatrix} A_x \\ B_x \end{bmatrix} = T \begin{bmatrix} A_c \\ B_c \end{bmatrix} \]  

(9)

Where \( T = T_{N,1} ... T_{N,m} \) and \( N \) is the total number of layers.

For the guiding modes, the fields should be evanescent in the cladding and the substrate layers.

References:


so \( A_x = 0 \) and \( B_x \), that results the characteristics equation [24]

\[ t_{11} (\beta) = 0 \]  

(10)

This equation need to be solved to find the complex propagation constants for both (TE/TM) polarizations.